

Issue Classification



Applicant(s)/Patent under Reexamination

CHANG ET AL.

Application/Control No.

10673916

Examiner

Apanius, Michael

Art Unit

3736

ORIGINAL

CLASS

600

SUBCLASS

561

INTERNATIONAL CLASSIFICATION

CLAIMED

A 6 1 B 5 / 00

NON-CLAIMED

CROSS REFERENCE(S)

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

Max Hindenburg
(Assistant Examiner)

9/11/2006
(Date)

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Total Claims Allowed:
8

Q. Lee
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9-12-06
(Date)

(Primary Examiner)

(Date) 9/11/06

O.G. Print Claim(s)
11

O.G. Print Figure
10